

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

Alain Rambach

Divisional of Serial No.: 09/890,841

For: **METHOD FOR DETECTING
BACTERIA CULTIVATED
UNDER ANAEROBIC
CONDITIONS**

Examiner: Irene Marx

Art Group: 1651

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Arlington, VA 22313-1450

Dear Sir:

In accordance with 37 CFR 1.56, Applicant hereby discloses the prior art references that have been submitted and/or cited in the following related application/patent:

Serial No.	Filing Date	Patent No.	Issue Date
09/890,841	8/2/01	---	---

Form PTO/SB/08B(substitute for form 1449A/PTO) is enclosed herewith. Copies of the references are not provided as permitted by 37 CFR 1.98(d).

Respectfully submitted,

BLAKELY, SOKOLOFF, TAYLOR & ZAFMAN

Date: 3/22/09

By: 

Eric S. Hymann Reg. No. 30,139

Form PTO-1449 (Modified)	Atty Docket No. 15675P368	Application No. 09/890,841
<i>List of Patents & Publications Statement</i>	Applicant(s): Christine Favier	
(Use several sheets if necessary)	Filing Date: August 02, 2001	Group No.:

U.S. PATENT DOCUMENTS

Exam. Initials		Document Number	Date	Name	Class	Sub- class	Filing Date (if appropriate)
	AA	3725203	04/03/1973	Sellers, Jr.	195	100	
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS

Exam. Initials		Document Number	Date	Country	Class	Sub- class	Translation Yes No	
	AL	0238243	10/03/1987	European	C12 Q 1	04		
	AM	2696476	07/10/1992	France	C12Q1	04		
	AN	2747394	15/04/1996	France	C12N1	20		
	AO							
	AP							
	AQ							

OTHER ART (Including Title, Author, Date, Pertinent Pages, etc.)

Exam. Initials		Document Identification
	AR	Chevalier P. et al, Journal of Microbiological Methods, vol. 13, no. 1, April 1, 1991, page 75-83
	AS	Patent Abstracts of Japan, vol. 016, no. 238 (C-0947), June 2, 1992, 1 page
	AT	

Examiner: _____ Date Considered: _____

Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication

Notice of References Cited

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	A	US-			
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	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	DIFCO Manual, 11th edition, 1998, pages 125-125 and 246-247
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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